

Search Notes

Application/Control No.

10/812,627

Examiner

Marie Patterson

Applicant(s)/Patent under
Reexamination

CHEN, EDDIE

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
036	4, 12	1/31/2006	<i>mdp</i>
<i>1</i>	14, 10	<i>1</i>	<i>1</i>
<i>1</i>	55, 21	<i>1</i>	<i>1</i>
<i>1</i>	43, 44	<i>1</i>	<i>1</i>
<i>1</i>	17R	<i>1</i>	<i>1</i>
036	17PW	1/31/2006	<i>mdp</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR